

**NAME**

CUTEST\_cfn\_threaded – CUTEst tool to evaluate function and constraints values.

**SYNOPSIS**

CALL CUTEST\_cfn\_threaded( status, n, m, X, f, C, thread )

**DESCRIPTION**

The CUTEST\_cfn\_threaded subroutine evaluates the value of the objective function and general constraint functions of the problem decoded from a SIF file by the script *sifdecoder* at the point X.

The problem under consideration is to minimize or maximize an objective function  $f(x)$  over all  $x \in R^n$  subject to general equations  $c_i(x) = 0$ , ( $i \in 1, \dots, m_E$ ), general inequalities  $c_i^l(x) \leq c_i(x) \leq c_i^u(x)$ , ( $i \in m_E + 1, \dots, m$ ), and simple bounds  $x^l \leq x \leq x^u$ . The objective function is group-partially separable and all constraint functions are partially separable.

**ARGUMENTS**

The arguments of CUTEST\_cfn\_threaded are as follows

**status** [out] - integer

the output status: 0 for a successful call, 1 for an array allocation/deallocation error, 2 for an array bound error, 3 for an evaluation error, 4 for an out-of-range thread,

**n** [in] - integer

the number of variables for the problem,

**m** [in] - integer

the total number of general constraints,

**X** [in] - real/double precision

an array which gives the current estimate of the solution of the problem,

**f** [out] - real/double precision

the value of the objective function evaluated at X,

**C** [out] - real/double precision

an array which gives the values of the general constraint functions evaluated at X. The i-th component of C will contain the value of  $c_i(x)$ ,

**thread** [in] - integer

thread chosen for the evaluation; threads are numbered from 1 to the value threads set when calling CUTEST\_csetup\_threaded.

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**SEE ALSO**

*CUTEst: a Constrained and Unconstrained Testing Environment with safe threads*,

N.I.M. Gould, D. Orban and Ph.L. Toint,

Technical Report, Rutherford Appleton Laboratory, 2013.

*CUTEr (and SifDec): A Constrained and Unconstrained Testing Environment, revisited*,

N.I.M. Gould, D. Orban and Ph.L. Toint,

ACM TOMS, **29**:4, pp.373-394, 2003.

*CUTE: Constrained and Unconstrained Testing Environment*, I. Bongartz, A.R. Conn, N.I.M. Gould and

Ph.L. Toint, ACM TOMS, **21**:1, pp.123-160, 1995.

cutest\_cfn\_threaded(3M), sifdecoder(1).